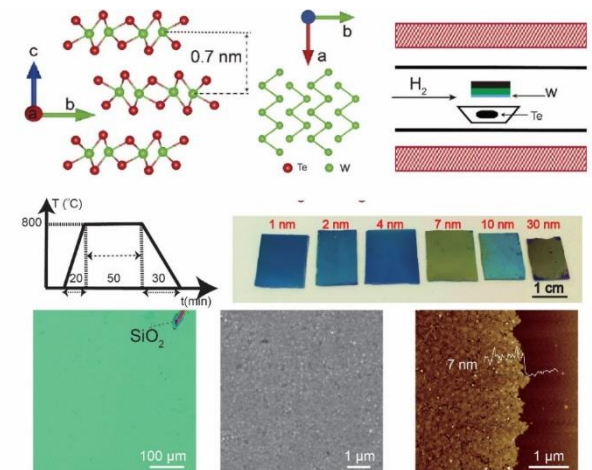
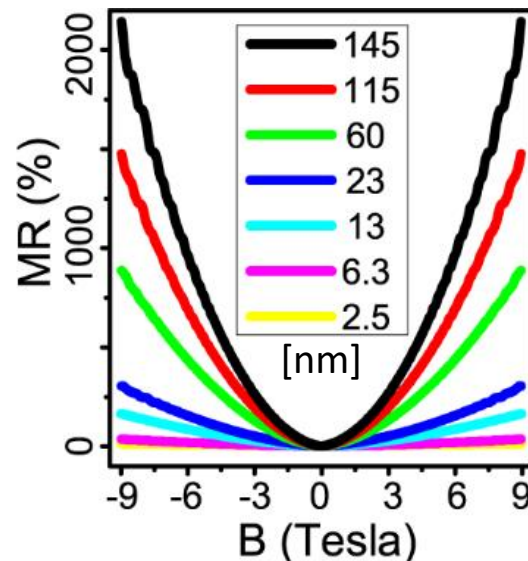
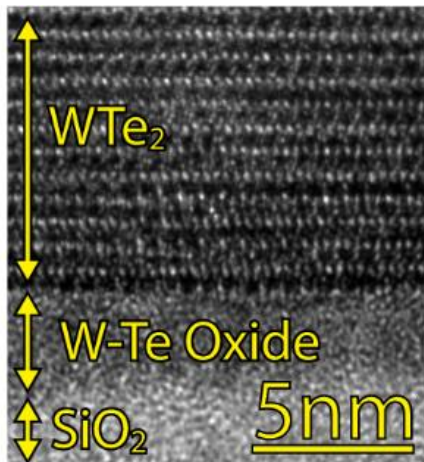


# Microscopic Origins of Physical Property Variations in WTe<sub>2</sub> Thin Films and Flakes

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Woods *et al.* (2017) *ACS Appl. Mater. Interfaces*, **9**, 23175

Zhou *et al.* (2017) *Adv. Funct. Mater.*, **27**, 1605928